

2.5-V INTEGRATED REFERENCE CIRCUIT

Check for Samples: LT1009M

FEATURES

- Excellent Temperature Stability
- Initial Tolerance: 0.2% Typical
- Dynamic Impedance: 0.6 Ω Typical
- Wide Operating Current Range
- Directly Interchangeable With LM136
- Needs No Adjustment for Minimum Temperature Coefficient
- Available in Military (–55°C/125°C)
 Temperature Range (1)
- (1) Custom temperature ranges available

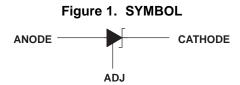
DESCRIPTION/ORDERING INFORMATION

The LT1009 reference circuit is a precision-trimmed 2.5-V shunt regulator featuring low dynamic impedance and a wide operating current range. The reference tolerance is achieved by on-chip trimming, which minimizes the initial voltage tolerance and the temperature coefficient, α_{VZ} .

Although the LT1009 needs no adjustments, a third terminal (ADJ) allows the reference voltage to be adjusted ±5% to eliminate system errors. In many applications, the LT1009 can be used as a terminal-for-terminal replacement for the LM136-2.5, which eliminates the external trim network.

The LT1009 uses include 5-V system references, 8-bit analog-to-digital converter (ADC) and digital-to-analog converter (DAC) references, and power-supply monitors. The device also can be used in applications such as digital voltmeters and current-loop measurement and control systems.

The LT1009 is characterized for operation from -55°C to 125°C.



ORDERING INFORMATION(1)

T _A	PACKAGE(BARE DIE) ⁽²⁾	ORDERABLE PART NUMBER			
-55°C to 125°C	CHIPTRAY	LT1009MKGD1			

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.
- (2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

BARE DIE INFORMATION

DIE THICKNESS	BACKSIDE FINISH	BOND PAD METALIZATION COMPOSITION
15 Mils	Silicon with backgrind	AlCu/TiW



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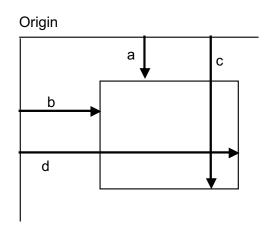
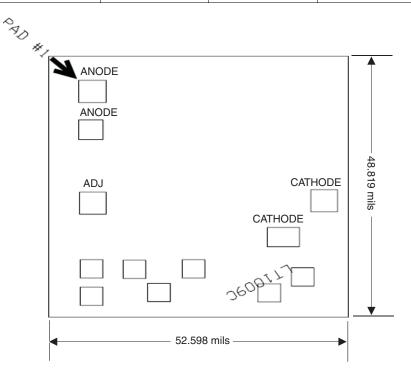


Table 1. Bond Pad Coordinates in Microns - Rev A

DISCRIPTION	PAD NUMBER	а	b	С	d
ANODE	1	127.000	127.000	243.840	243.840
ANODE	2	335.280	127.000	439.420	231.140
ADJ	3	716.280	130.810	833.120	243.840
Do not connect	4	1073.150	133.350	1169.670	229.870
Do not connect	5	1217.930	133.350	1314.450	229.870
Do not connect	6	1075.690	316.230	1172.210	412.750
Do not connect	7	1197.610	420.370	1294.130	516.890
Do not connect	8	1073.150	567.690	1169.670	664.210
Do not connect	9	1200.150	890.270	1296.670	986.790
Do not connect	10	1116.330	1032.510	1212.850	1129.030
CATHODE	11	902.970	929.640	1004.570	1066.800
CATHODE	12	703.580	1115.060	820.420	1229.360



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Figure 2. SCHEMATIC **CATHODE** Q14 Q11 24 $k\Omega$ **24 k**Ω ≷ 6.6 $k\Omega$ Q8 20 pF 30 pF Q10 10 $\mathbf{k}\Omega$ $\mathbf{500}\,\Omega$ Q2 Q9 $\mathbf{30}\ \mathbf{k}\Omega$ Q4 ADJ Q1 $6.6 k\Omega$ Q3 Q6 Q12 Q5 Q13 $\mathbf{720}\,\Omega$ ANODE

NOTE: All component values shown are nominal.

ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
I_R	Reverse current		20	mA
IF	Forward current		10	mA
T_{J}	Operating virtual junction temperature ⁽²⁾		150	°C
T _{stg}	Storage temperature range	-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. Maximum power dissipation is a function of $T_J(max)$, θ_{JA} , and T_A . The maximum allowable power dissipation at any allowable ambient

RECOMMENDED OPERATING CONDITIONS

		MIN	MAX	UNIT
T_A	Operating free-air temperature range	-55	125	°C

Product Folder Links: LT1009M

temperature is P_D = (T_J(max) - T_A)/θ_{JA}. Operating at the absolute maximum T_J of 150°C can affect reliability.



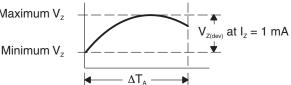
ELECTRICAL CHARACTERISTICS

at specified free-air temperature

	DADAMETED	TEGT CONDITIONS	_	LT1009M				
PARAMETER		TEST CONDITIONS T _A		MIN	TYP MAX		UNIT	
M	Deference voltoge	1 1	25°C	2.49	2.5	2.51	V	
V _Z	Reference voltage	$I_Z = 1 \text{ mA}$	Full range	2.46		2.535	V	
V _F	Forward voltage	I _F = 2 mA	25°C	0.4		1	V	
	A diversion and war are	$I_Z = 1 \text{ mA},$ $V_{ADJ} = \text{GND to } V_Z$	2500	125			\/	
	Adjustment range	$I_Z = 1 \text{ mA},$ $V_{ADJ} = 0.6 \text{ V to } V_Z - 0.6 \text{ V}$	25°C	45			mV	
$\Delta V_{Z(temp)}$	Change in reference voltage with temperature		Full range			15	mV	
αV_Z	Average temperature coefficient of reference voltage (1)	I _Z = 1 mA, V _{ADJ} = open	Full range		20	35	ppm/ °C	
A \ /	Change in reference	100 100 1	25°C		6	10	>/	
ΔV_Z	voltage with current	$I_Z = 400 \mu\text{A} \text{ to } 10 \text{mA}$	Full range			12	mV	
$\Delta V_Z/\Delta t$	Long-term change in reference voltage	I _Z = 1 mA	25°C		20		ppm/ khr	
7	Deference impedance	1 1 m 1	25°C		0.6	1.6	0	
Z_Z	Reference impedance	$I_Z = 1 \text{ mA}$	Full range			1.8	Ω	

(1) The deviation parameter V_{Z(dev)} is defined as the difference between the maximum and minimum values obtained over the recommended operating temperature range, measured at I_Z = 1 mA. The average full-range temperature coefficient of the reference voltage (αV_Z) is defined as:

$$|\alpha V_z| \left(\frac{ppm}{{}^{\circ}C}\right) = \frac{\left(\frac{V_{z(dev)}}{V_z \text{ at } 25{}^{\circ}C}\right) \times 10^6}{\Delta T}$$



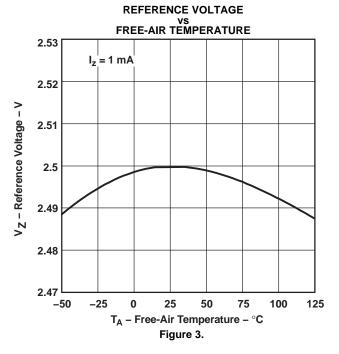
 αV_Z can be positive or negative, depending upon whether the minimum V_Z or maximum V_Z , respectively, occurs at the lower temperature.

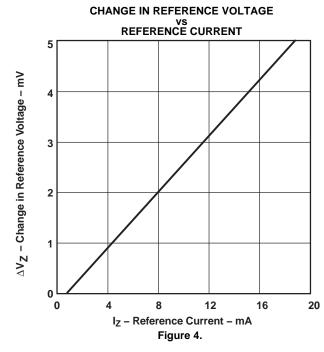
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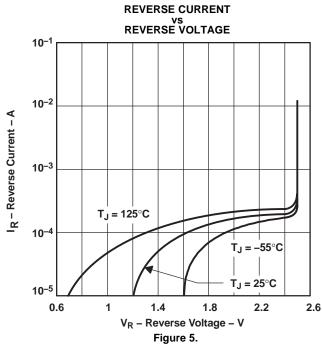


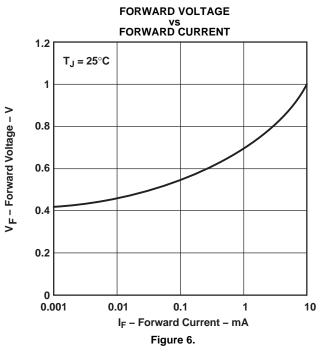
TYPICAL CHARACTERISTICS

Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.









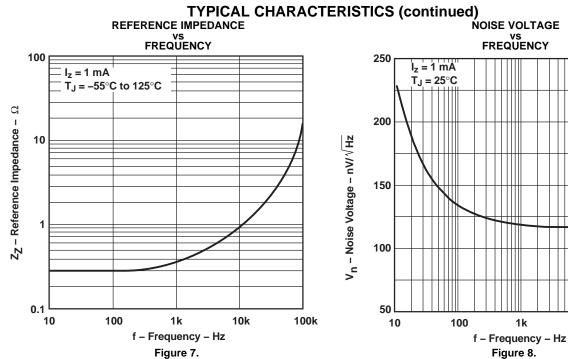
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10k

100k



3.5 3

2.5

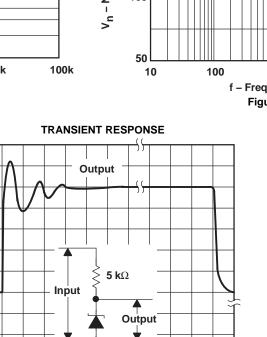
2 1.5 1 0.5

0

8

0

Input and Output Voltages - V



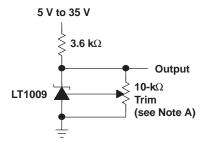
 $\textbf{t-Time}-\mu\textbf{s}$ Figure 9.

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Input



APPLICATION INFORMATION



A. This does not affect temperature coefficient. It provides ±5% trim range.

Figure 10. 2.5-V Reference

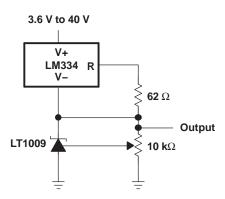


Figure 11. Adjustable Reference With Wide Supply Range

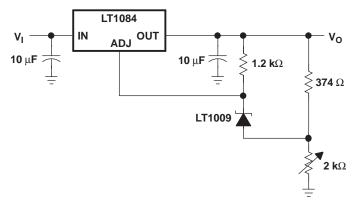


Figure 12. Power Regulator With Low Temperature Coefficient

Product Folder Links: LT1009M



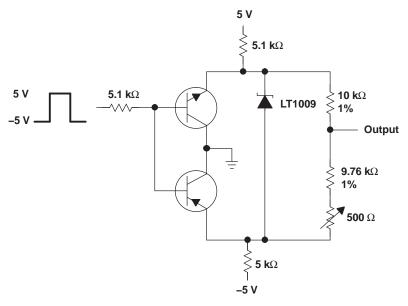


Figure 13. Switchable ±1.25-V Bipolar Reference

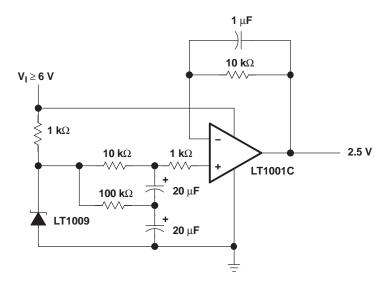


Figure 14. Low-Noise 2.5-V Buffered Reference

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
LT1009MKGD1	Active	Production	XCEPT (KGD) 0	100 NOT REQUIRED	Yes	Call TI	N/A for Pkg Type	-55 to 125	
LT1009MKGD1.A	Active	Production	XCEPT (KGD) 0	100 NOT REQUIRED	Yes	Call TI	N/A for Pkg Type	-55 to 125	

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF LT1009M:

Catalog: LT1009

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



PACKAGE OPTION ADDENDUM

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NOTE: Qualified Version Definitions:

 $_{\bullet}$ Catalog - TI's standard catalog product

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